## Analytical Reference Materials International

## Certificate of Analysis Certified Reference Material



Grade: AISI 302 / UNS S30200

Part Number (Q.A. NO.): IARM 241C

Certification Date: 12/01/2004 Certificate No.: 241C-12012004-IARM-F Revision Date: 12/01/2004

## **Interpretation of Data**

- 1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community and are reported as % wt. unless otherwise noted.
- 2. Any data reported and enclosed by a **parentheses** ( ) is a "best estimate" and is NOT CERTIFIED. This data could not be quantified sufficiently for certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
- 3. The "Inter-laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in **brackets** [ ] **indicates further testing is in process.**
- 4. The "±Estimated Uncertainty" is enclosed by a parentheses ( ) below the individual element's concentration and is based on a Confidence Interval at 95%. Included in this estimated uncertainty, are the combined effects of method imprecision, material inhomogeneity, and any bias between methods.

Important: A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

Aluminum	Boron	Carbon	Cobalt	Chromium	Copper 0.52 (0.01)	Manganese
0.003	0.0005	0.069	0.058	17.80		1.50
(0.001)	(0.0001)	(0.001)	(0.002)	(0.03)		(0.005)
Molybdenum	Nitrogen	Niobium	Nickel	Oxygen	Phosphorus 0.043 (0.001)	<u>Sulfur</u>
0.117	0.0478	0.003	8.05	0.007		0.030
(0.004)	(0.0003)	(0.001)	(0.02)	(0.001)		(0.001)
Silicon 0.630 (0.003)	<u>Tantalum</u> (0.005)	<u>Tin</u> 0.0057 (0.0004)	<u>Titanium</u> 0.002 (0.0005)	Vanadium 0.039 (0.002)	Tungsten 0.01 (0.003)	<u>Zirconium</u>

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

Allegheny Ludlum Corp. - Brackenridge, PA

Allvac Lockport - Lockport, NY

Carpenter Technology Corporation - Reading, PA Huntington Alloys Corporation - Huntington, WV Laboratory Testing, Inc. - Hatfield, PA

MetalTek International, Inc. - Waukesha, WI

Allvac - Monroe, NC

Anderson Laboratories, Inc. - Greendale, WI Crucible Specialty Metals - Syracuse, NY Jorgensen Forge Corp. - Seattle, WA Lockheed Martin Astronautics - Littleton, CO Timken Latrobe Steel Co. - Latrobe, PA

Traceability: All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are: NIST 1152, IARM 2B, 241B, LECO 501-501, 501-533, 502-106, 847942, NIST C1152A, IARM 2F, 27C, 241B, BS CA304-1, CS-304, ES0115A, LECO 501-647, IARM 2B, 2C, CarTech 303, NIST 1761, 1762, 1763, 1764, 1765, 1766, 1767, 1261, 1262, 1263, 1264, 1265, IARM 241B, LECO 771-553, 771-550, IARM 241A, 241B, 2F, 234A, 234B, BS 81G, CSN2-2, LECO 501-502, 501-675, 502-106, NIST 344, BS 81V, 81T, SS3952, LECO 501-553, NIST 1230, LECO 501-675, 501-645, NIST 1152, IARM 241B, 2B, 2C, 2D, 2E, BS 81C, 81D, LECO 501-503, 501-553, NIST 3107, 3155, 3161A, IARM 1A, 2A, 2B, 2C, 6A, 6B, 8A, 8B, 9B, 10B, 13B, 154A, BS 89D, 89E, 17-5A, 17-4PHB, 9941, 9942, 317L, LECO 501-504, 501-502, 501-504, 501-643, 501-644, 501-646, 501-647, 501-674, 501-676, NIST 121D, IARM 1B, 6B, LECO 501-553, 501-644, NIST 131G, 160B, 337A, HAS 321A, 330B, 400M, 600C, 600T, 718Q, 805B, 902B, REF 304A, LECO 501-550, 502-256, IARM 241B

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

See Reverse Side for Statistical Data and Additional Information Regarding this Material.

The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 12/01/2004.

241C	Al	В	С	Со	Cr	Cu	Mn	Мо	N	Nb	Ni	0	Р	S	Se
1	0.0014	0.0005	0.0705	0.055	17.87	0.513	1.490	0.109	0.0483	0.002	8.050	0.0068	0.042	0.030	< 0.001
2	0.0018	0.00065	0.0676	0.057	17.849	0.532	1.502	0.119	0.0476	0.0022	8.027	0.0053	0.043	0.0316	<0.0001
3	0.0034	0.0006	0.0689	0.058	17.820	0.525	1.497	0.119	0.0471	0.006	8.045	0.0060	0.0427	0.0310	<0.0001
4	0.0022	0.0008	0.073	0.0606	17.80	0.508	1.49	0.128	0.0483	0.0044	8.06	0.0057	0.042	0.032	
5	0.0035	0.00025	0.0707	0.056	17.805	0.525	1.490	0.118	0.0479	0.0033	8.02	0.0083	0.043	0.0306	
6	0.0048	0.0006	0.0690	0.055	17.843	0.513	1.509	0.114	0.04753	0.0035	8.070	0.00748	0.0423	0.0298	
7	0.00449	0.0004	0.0691	0.0609	17.759	0.52988	1.501	0.126	0.0482	0.0040	8.017	0.0084	0.0424	0.0308	
8	0.0029	0.0005	0.06780	0.06423	17.70181	0.531	1.49182	0.11231	0.0480	0.002	7.99702	0.0083	0.04291	0.02893	
9	0.003	0.0006	0.0717	0.056	17.80	0.526	1.504	0.114	0.0476	0.0011	8.08		0.043	0.0325	
10	0.0043	0.0003	0.067	0.055	17.819	0.5080	1.4855	0.119		0.0013	8.078		0.0442	0.0315	
11	0.0053		0.06875	0.0525	17.812	0.510	1.489	0.1149		0.0039	8.028		0.041	0.02718	
12	0.0034		0.069	0.065	17.74	0.505	1.50	0.107			8.08			0.0296	
13			0.0673	0.0568	17.740						8.04				
Mean	0.0034	0.0005	0.0693	0.0578	17.7968	0.5188	1.4958	0.1167	0.0478	0.0031	8.0455	0.0070	0.0426	0.0305	
STDV.	0.0012	0.0002	0.0018	0.0038	0.0487	0.0102	0.0074	0.0062	0.0004	0.0015	0.0270	0.0013	0.0008	0.0015	
Certified	0.003	0.0005	0.069	0.058	17.80	0.52	1.50	0.117	0.0478	0.003	8.05	0.007	0.043	0.030	
95% C.I.	0.001	0.0001	0.001	0.002	0.03	0.01	0.005	0.004	0.0003	0.001	0.02	0.001	0.001	0.001	
Methods	A,I,O	I,O	C,O	X,A,I,O	X,W,O	X,I,O	X,I,O	X,I,O	F	X,I,O	X,W,O	F	X,A,O	X,C,O	

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G = GDMS, H = Hollow Cathode OE

241C	Si	Sn	Ta	Ti	٧	W	Ag	As	Bi	Ca	Н	Mg	Pb	Zn	Zr
1	0.629	0.0060	0.003	0.001	0.036	0.011	0.0003	0.0012	0.0006	0.0012		< 0.001	0.0002	< 0.0001	0.002
2	0.627	0.0064	0.010	0.0014	0.034	0.007	0.00002	0.001	< 0.001	0.0016		< 0.001	0.0031	< 0.0001	0.0016
3	0.625	0.0055	0.003	0.002	0.037	0.024		0.0039	< 0.00001	0.0074		0.0024	0.0011		0.0021
4	0.638	0.0053	0.002	0.0016	0.044	0.022		0.0056				0.00041	0.0008		0.001
5	0.631	0.0054	0.0044	0.0015	0.040	0.013							0.00003		0.0009
6	0.631	0.0060		0.0026	0.0383	0.00975							< 0.0001		
7	0.625	0.0062		0.00284	0.0361	0.00980									
8	0.63011	0.0060		0.0022	0.039	0.014									
9	0.620	0.00483		0.002	0.038	0.013									
10	0.624	0.0051		0.0022	0.0405	0.0124									
11	0.634			0.0028	0.040	0.017									
12	0.64			0.0035	0.0403	0.0105									
13	0.634														
Mean	0.6299	0.0057	0.0045	0.0021	0.0386	0.0136	0.0002	0.0029	0.0006	0.0034		0.0014	0.0010		0.0015
STDV.	0.0057	0.0005	0.0032	0.0007	0.0026	0.0051	0.0002	0.0022		0.0035		0.0014	0.0012		0.0006
Certified	0.630	0.0057	(0.005)	0.002	0.039	0.01		<0.005							(0.002)
95% C.I.	0.003	0.0004		0.0005	0.002	0.003									
Methods	X,W,I,O	X,A,I,O	X,I,O	X,I,O	X,I,O	X,I,O		A,I,O							X,I

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G = GDMS, H = Hollow Cathode OE

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1981-(E) list the following:

<u>Certifying Body:</u> A technically competent body (organization or firm, public or private) that issues a Reference Material Certificate. The only generally accepted certifying body in the United States is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD.

**Reference Material (RM):** A material or substance with one or more properties which are sufficiently well established to be used for calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

<u>Certified Reference Material (CRM):</u> A reference material with one or more properties whose values are certified by a technically valid procedure accompanied by or traceable to a certificate or other documentation, which is issued by a Certifying Body.

Inter-Laboratory Analysis Program (ILAP): Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter-laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol, and treatment of data resulting from this inter-laboratory program were performed utilizing the guidelines established in ASTM E691-87.

<u>Methods of Analysis:</u> In view of the fact, that the "Inter-Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen, and Oxygen are the result of combustion instrument procedures.

Selection of Materials: A "batch" or "series" is defined as a single bar of one continuous length. The majority of materials are in wrought condition. Other methods of manufacture are utilized as a last resort, only in the case of those materials being unavailable in wrought condition. "Batch" samples are taken by removing a one-inch cross section for every thirteen inches of total length from the entire bar. Twenty-five percent of the one inch cross section is converted to chips for analysis by classical wet chemistry, ICP, AA, and combustion procedures and seventy-five percent remains in a solid disk form for OES and X-Ray analysis where applicable. Each member of the ILAP is furnished both a solid sample and the corresponding supply of chips from a specific location on the batch bar. This massive sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data.

Certified by:

William D. Britt, President/General Manager Analytical Reference Materials International Certificate No.: 241C-12012004-ARM-F Certification Date: 12/01/2004

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